

**Notice of References Cited**

Application/Control

10/075,153

Applicant(s)/Patent Under  
Reexamination  
MASE ET AL.

Examiner

Kumiko C. Koyama

Art Unit

2876

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,237,164	08-1993	Takada, Hirohisa	235/487
	B	US-6,408,286	06-2002	Heiden, Richard W.	705/408
	C	US-6,267,291	07-2001	Blankenship et al.	235/375
	D	US-5,514,123	05-1996	Adolf et al.	604/411
	E	US-6,297,322	10-2001	Ding et al.	525/191
	F	US-5,319,182	06-1994	Havens et al.	235/462.42
	G	US-4,884,904	12-1989	Berquist, John F.	400/120.16
	H	US-4,559,872	12-1985	Perra, Jr., Andrew G.	101/228
	I	US-4,983,817	01-1991	Dolash et al.	235/462.04
	J	US-5,164,573	11-1992	Ishikawa, Hiroshi	235/454
	K	US-5,187,546	02-1993	Johnston, James S.	356/499
	L	US-5,288,976	02-1994	Citron et al.	235/375
	M	US-6,017,125	01-2000	Vann, Charles S.	359/529

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.